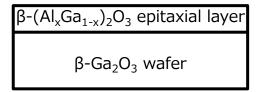
Standard specifications of $\frac{\text{Standard specifications of}}{10x15\text{mm}^2 \beta - (\text{Al}_x\text{Ga}_{1-x})_2\text{O}_3 \text{ epitaxial wafer (by MBE)}}$

Epitaxial layer

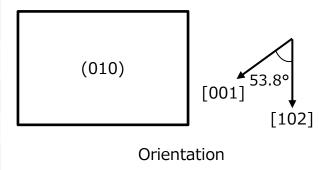
Items	Specifications	
Al mole fraction	x≦0.23	
Dopant	Si (n-type)	
Doping concentration	≤1x10 ¹⁸ cm ⁻³	
Thickness	≦60 nm	



Cross section of β -Ga₂O₃ epitaxial wafer

Wafer

Items	Specifications	
Dopant	Sn (n-type)	Fe (semi-insulating)
Doping concentration	1~9x10 ¹⁸ cm ⁻³	-
Resistivity	-	≥10 ¹⁰ Ωcm
Orientation	(010)	
Size	10x15 mm ²	
Thickness	0.5 mm	
XRD FWHM	≦150 arcsec	
Off set angle	0°±1°	



Novel Crystal Technology, Inc.

2021.4.30

Remarks

3 The specifications are subject to change without notice.

¹ These products must be used for research and development purpose only.

² The substrates must not be used as a seed crystal.